

# VNW100N04

# "OMNIFET": FULLY AUTOPROTECTED POWER MOSFET

#### **PRELIMINARY DATA**

TYPE	V <sub>clamp</sub>	R <sub>DS(on)</sub>	l <sub>lim</sub>
VNW100N04	42 V	$0.012~\Omega$	100 A

- LINEAR CURRENT LIMITATION
- THERMAL SHUT DOWN
- SHORT CIRCUIT PROTECTION
- INTEGRATED CLAMP
- LOW CURRENT DRAWN FROM INPUT PIN
- DIAGNOSTIC FEEDBACK THROUGH INPUT PIN
- ESD PROTECTION
- DIRECT ACCESS TO THE GATE OF THE POWER MOSFET (ANALOG DRIVING)
- COMPATIBLE WITH STANDARD POWER MOSFET
- STANDARD TO-247 PACKAGE

# TO-247

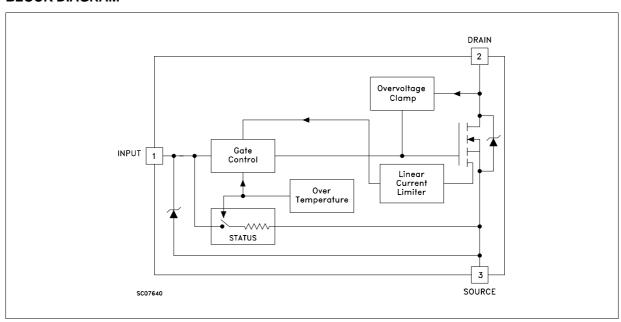
#### **DESCRIPTION**

The VNW100N04 is a monolithic device made using SGS-THOMSON Vertical Intelligent Power M0 Technology, intended for replacement of standard power MOSFETS in DC to 50 KHz applications. Built-in thermal shut-down, linear

current limitation and overvoltage clamp protect the chip in harsh environments.

Fault feedback can be detected by monitoring the voltage at the input pin.

#### **BLOCK DIAGRAM**



September 1996 1/11

# **ABSOLUTE MAXIMUM RATING**

Symbol	Parameter	Value	Unit
$V_{DS}$	Drain-source Voltage (V <sub>in</sub> = 0)	Internally Clamped	V
V <sub>in</sub>	Input Voltage 18		V
ID	Drain Current Internally L		Α
$I_R$	Reverse DC Output Current	-100	Α
$V_{\text{esd}}$	Electrostatic Discharge (C= 100 pF, R=1.5 KΩ)	2000	V
P <sub>tot</sub>	Total Dissipation at T <sub>c</sub> = 25 °C	208	W
Tj	T <sub>j</sub> Operating Junction Temperature Internally L		°C
Tc	Case Operating Temperature	Internally Limited	°C
T <sub>stg</sub>	Storage Temperature	-55 to 150	°C

# THERMAL DATA

R <sub>thj-case</sub>	Thermal Resistance Junction-case	Max	0.6	°C/W
$R_{thj-amb}$	Thermal Resistance Junction-ambient	Max	30	°C/W

# **ELECTRICAL CHARACTERISTICS** ( $T_{case} = 25$ $^{o}C$ unless otherwise specified) OFF

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
VCLAMP	Drain-source Clamp Voltage	I <sub>D</sub> = 50 A V <sub>in</sub> = 0	36	42	48	V
V <sub>CLTH</sub>	Drain-source Clamp Threshold Voltage	$I_D = 2 \text{ mA}$ $V_{in} = 0$	35			V
VINCL	Input-Source Reverse Clamp Voltage	l <sub>in</sub> = -1 mA	-1		-0.3	V
I <sub>DSS</sub>	Zero Input Voltage Drain Current (V <sub>in</sub> = 0)	$V_{DS} = 13 \text{ V} $ $V_{in} = 0$ $V_{DS} = 25 \text{ V} $ $V_{in} = 0$			50 200	μA μA
liss	Supply Current from Input Pin	V <sub>DS</sub> = 0 V V <sub>in</sub> = 10 V		250	500	μΑ

# ON (\*)

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
$V_{IN(th)}$	Input Threshold Voltage	$V_{DS} = V_{in}$ $I_D + Ii_n = 1 \text{ mA}$	0.8		3	V
R <sub>DS(on)</sub>	Static Drain-source On Resistance	$V_{in} = 10 \text{ V}$ $I_D = 50 \text{ A}$ $V_{in} = 5 \text{ V}$ $I_D = 50 \text{ A}$			0.012 0.015	Ω Ω

## **DYNAMIC**

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
gfs (*)	Forward Transconductance	V <sub>DS</sub> = 13 V I <sub>D</sub> = 50 A	40	60		S
Coss	Output Capacitance	V <sub>DS</sub> = 13 V f = 1 MHz V <sub>in</sub> = 0		2000	3000	pF



# **ELECTRICAL CHARACTERISTICS** (continued)

SWITCHING (\*\*)

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
t <sub>d(on)</sub>	Turn-on Delay Time	V <sub>DD</sub> = 15 V I <sub>d</sub> = 50 A		110	250	ns
t <sub>r</sub>	Rise Time	$V_{gen} = 10 \text{ V}$ $R_{gen} = 10 \Omega$		500	900	ns
t <sub>d(off)</sub>	Turn-off Delay Time	(see figure 3)		1000	1800	ns
t <sub>f</sub>	Fall Time			600	1000	ns
t <sub>d(on)</sub>	Turn-on Delay Time	V <sub>DD</sub> = 15 V I <sub>d</sub> = 50 A		2.2	3.5	μs
t <sub>r</sub>	Rise Time	$V_{gen} = 10 \text{ V}$ $R_{gen} = 1000 \Omega$		3.5	6	μs
t <sub>d(off)</sub>	Turn-off Delay Time	(see figure 3)		22	30	μs
t <sub>f</sub>	Fall Time			12	18	μs
(di/dt) <sub>on</sub>	Turn-on Current Slope	$V_{DD} = 15 \text{ V}$ $I_D = 50 \text{ A}$		55		A/μs
		$V_{in} = 10 \text{ V}$ $R_{gen} = 10 \Omega$				
Qi	Total Input Charge	$V_{DD} = 15 \text{ V}$ $I_{D} = 50 \text{ A}$ $V_{in} = 10 \text{ V}$		190		nC

## SOURCE DRAIN DIODE

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
V <sub>SD</sub> (*)	Forward On Voltage	I <sub>SD</sub> = 50 A V <sub>in</sub> = 0			1.6	V
t <sub>rr</sub> (**)	Reverse Recovery Time	$I_{SD} = 50 \text{ A}$		800		ns
Q <sub>rr</sub> (**)	Reverse Recovery Charge	(see test circuit, figure 5)		5		μC
I <sub>RRM</sub> (**)	Reverse Recovery Current			15		А

# **PROTECTION**

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
l <sub>lim</sub>	Drain Current Limit	$V_{in} = 10 \text{ V}$ $V_{DS} = 13 \text{ V}$ $V_{in} = 5 \text{ V}$ $V_{DS} = 13 \text{ V}$	35 35	50 50	65 65	A A
t <sub>dlim</sub> (**)	Step Response Current Limit	V <sub>in</sub> = 10 V V <sub>in</sub> = 5 V		50 130	80 200	μs μs
T <sub>jsh</sub> (**)	Overtemperature Shutdown		170			°C
T <sub>jrs</sub> (**)	Overtemperature Reset		155			°C
I <sub>gf</sub> (**)	Fault Sink Current	V <sub>in</sub> = 10 V V <sub>DS</sub> = 13 V V <sub>in</sub> = 5 V V <sub>DS</sub> = 13 V		50 20		mA mA
E <sub>as</sub> (**)	Single Pulse Avalanche Energy	starting $T_j = 25$ °C $V_{DD} = 20$ V $V_{in} = 10$ V $R_{gen} = 1$ K $\Omega$ L = 10 mH	4			J



<sup>(\*)</sup> Pulsed: Pulse duration = 300 μs, duty cycle 1.5 % (\*\*) Parameters guaranteed by design/characterization

#### **PROTECTION FEATURES**

During normal operation, the Input pin is electrically connected to the gate of the internal power MOSFET. The device then behaves like a standard power MOSFET and can be used as a switch from DC to 50 KHz. The only difference from the user's standpoint is that a small DC current (I<sub>iss</sub>) flows into the Input pin in order to supply the internal circuitry.

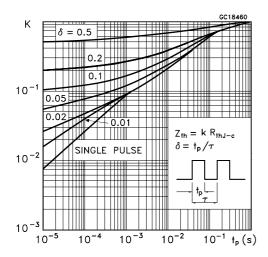
The device integrates:

- OVERVOLTAGE CLAMP PROTECTION: internally set at 42V, along with the rugged avalanche characteristics of the Power MOSFET stage give this device unrivalled ruggedness and energy handling capability. This feature is mainly important when driving inductive loads.
- LINEAR CURRENT LIMITER CIRCUIT: limits the drain current ld to llim whatever the Input pin voltage. When the current limiter is active, the device operates in the linear region, so power dissipation may exceed the capability of the heatsink. Both case and junction temperatures increase, and if this phase lasts long enough, junction temperature may reach the overtemperature threshold T<sub>ish</sub>.
- OVERTEMPERATURE AND SHORT CIRCUIT PROTECTION: these are based on sensing the chip temperature and are not dependent on the input voltage. The location of the sensing element on the chip in the power stage area ensures fast, accurate detection of the junction temperature. Overtemperature cutout occurs at minimum 170°C. The device is automatically restarted when the chip temperature falls below 155°C.
- STATUS FEEDBACK: In the case of an overtemperature fault condition, a Status Feedback is provided through the Input pin. The internal protection circuit disconnects the input from the gate and connects it instead to ground via an equivalent resistance of 100  $\Omega$ . The failure can be detected by monitoring the voltage at the Input pin, which will be close to ground potential.

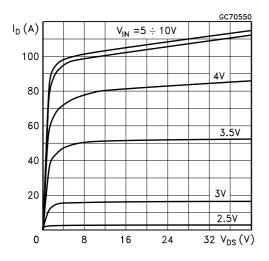
Additional features of this device are ESD protection according to the Human Body model and the ability to be driven from a TTL Logic circuit (with a small increase in R<sub>DS(on)</sub>).



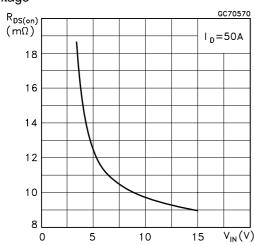
# Thermal Impedance



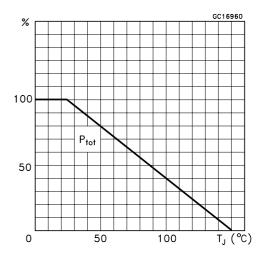
# **Output Characteristics**



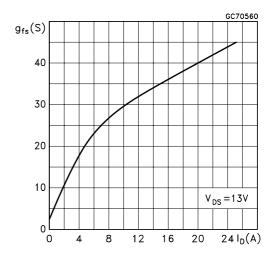
# Static Drain-Source On Resistance vs Input Voltage



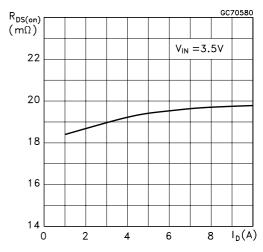
# **Derating Curve**



#### Transconductance

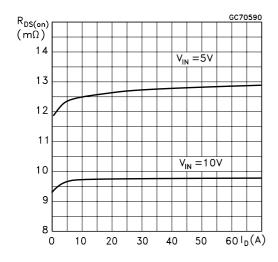


# Static Drain-Source On Resistance

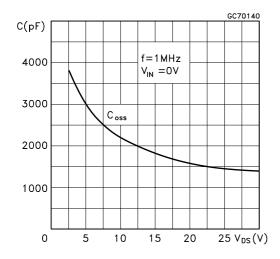




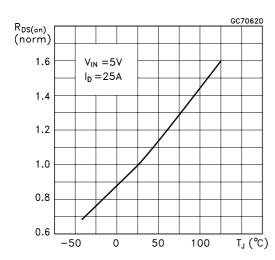
## Static Drain-Source On Resistance



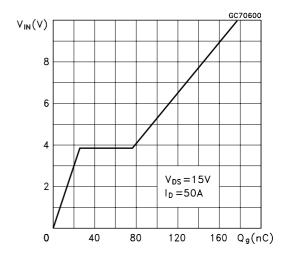
#### Capacitance Variations



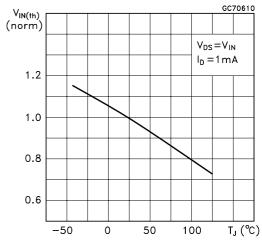
# Normalized On Resistance vs Temperature



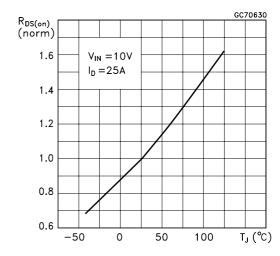
## Input Charge vs Input Voltage



# Normalized Input Threshold Voltage vs Temperature

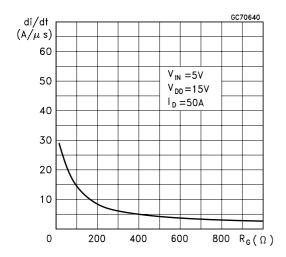


# Normalized On Resistance vs Temperature

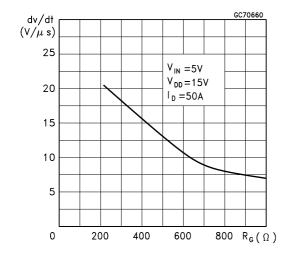


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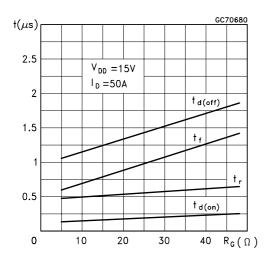
## Turn-on Current Slope



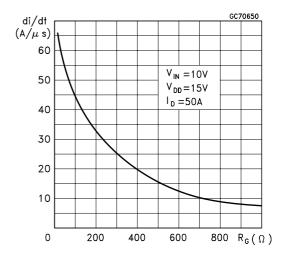
# Turn-off Drain-Source Voltage Slope



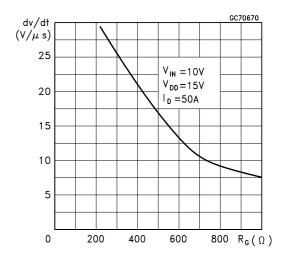
# Switching Time Resistive Load



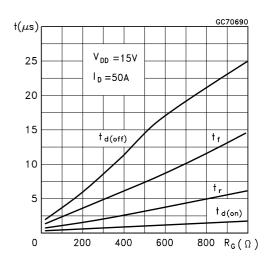
## Turn-on Current Slope



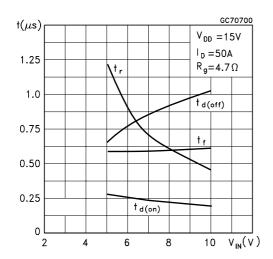
Turn-off Drain-Source Voltage Slope



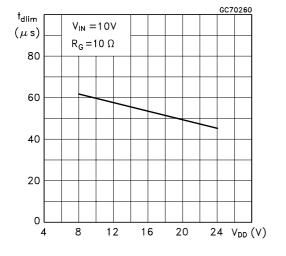
# Switching Time Resistive Load



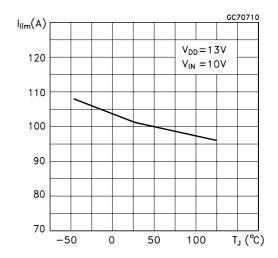
# Switching Time Resistive Load



# Step Response Current Limit



# Current Limit vs Junction Temperature



## Source Drain Diode Forward Characteristics



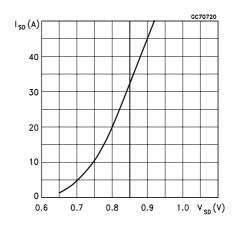


Fig. 1: Unclamped Inductive Load Test Circuits

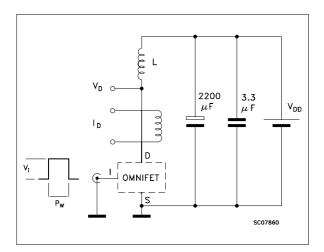
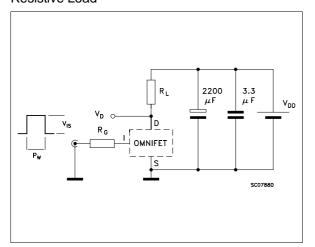


Fig. 3: Switching Times Test Circuits For Resistive Load



**Fig. 5:** Test Circuit For Inductive Load Switching And Diode Recovery Times

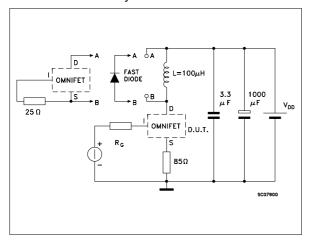


Fig. 2: Unclamped Inductive Waveforms

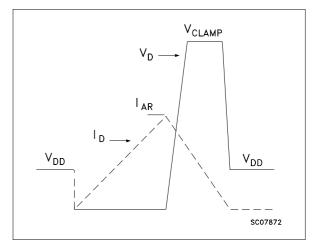


Fig. 4: Input Charge Test Circuit

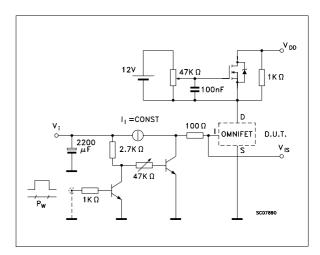
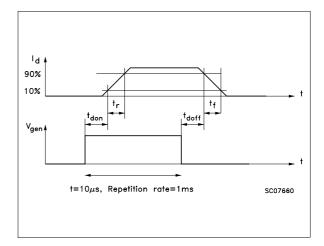
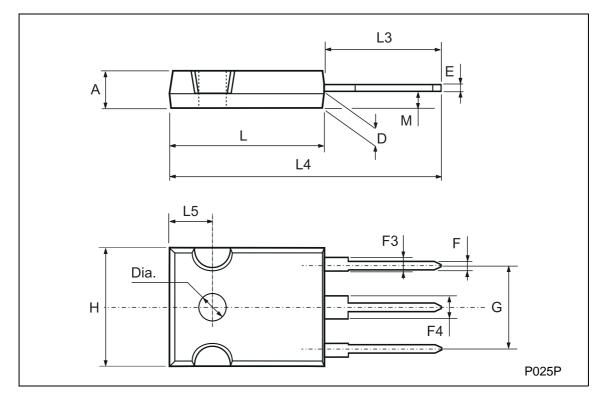


Fig. 6: Waveforms



# **TO-247 MECHANICAL DATA**

DIM.	mm			inch			
DIIVI.	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.	
А	4.7		5.3	0.185		0.209	
D	2.2		2.6	0.087		0.102	
E	0.4		0.8	0.016		0.031	
F	1		1.4	0.039		0.055	
F3	2		2.4	0.079		0.094	
F4	3		3.4	0.118		0.134	
G		10.9			0.429		
Н	15.3		15.9	0.602		0.626	
L	19.7		20.3	0.776		0.779	
L3	14.2		14.8	0.559	0.413	0.582	
L4		34.6			1.362		
L5		5.5			0.217		
М	2		3	0.079		0.118	
Dia	3.55		3.65	0.140		0.144	



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